

Notice of References Cited	Application/Control No. 10/021,439	Applicant(s)/Patent Under Reexamination CHOI, SANG JUN	
	Examiner Feben M. Haile	Art Unit 2663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,741,598 B1	05-2004	Murakami et al.	370/395.6
	B	US-6,574,223 B1	06-2003	Brueckheimer et al.	370/395.6
	C	US-6,594,267 B1	07-2003	Dempo, Hiroshi	370/395.64
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.